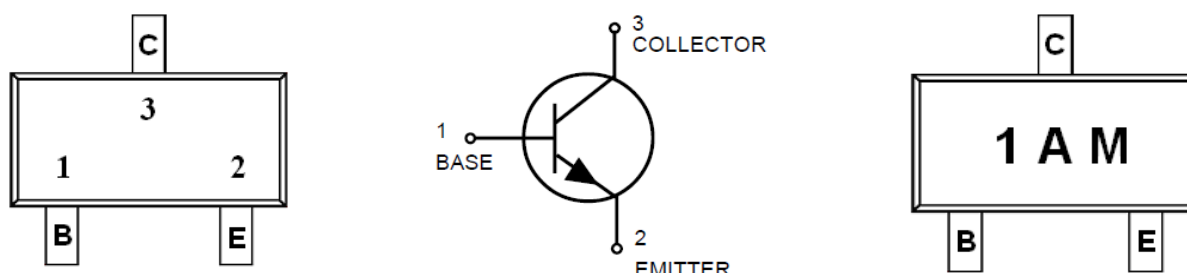




**Features**

- This device is designed as a general purpose amplifier and switch.
- The useful dynamic range extends to 100 mA as a switch and to 100 MHz as an amplifier.

**Pin Description ( SOT-23 )**



**Ordering Information**

Part Ordering No.	Part Marking	Package	Unit	Quantity
AFT3904T1S23RG	1AM	SOT-23	Tape & Reel	3000 EA

**Absolute Maximum Ratings** ( $T_A=25^\circ\text{C}$  Unless otherwise noted)

Symbol	Parameter	Value	Unit
$V_{CEO}$	Collector-Emitter Voltage	40	V
$V_{CBO}$	Collector-Base Voltage	60	V
$V_{EBO}$	Emitter-Base Voltage	6.0	V
$I_C$	Collector Current - Continuous	200	mA
$T_J, T_{stg}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

Notes :

- 1) These ratings are based on a maximum junction temperature of 150 degrees C.
- 2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

**Thermal Characteristics** ( $T_A=25^\circ\text{C}$  Unless otherwise noted)

Symbol	Parameter	Max.	Unit
$P_D$	Total Device Dissipation FR- 5 Board, (1) $T_A = 25^\circ\text{C}$	225	mW
	Derate above $25^\circ\text{C}$	1.8	mW/ $^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	556	$^\circ\text{C}/\text{W}$
$P_D$	Total Device Dissipation Alumina Substrate, (2) $T_A = 25^\circ\text{C}$	300	mW
	Derate above $25^\circ\text{C}$	2.4	mW/ $^\circ\text{C}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	417	$^\circ\text{C}/\text{W}$

Notes :

- 1) FR-5 = 1.0 x 0.75 x 0.062 in.
- 2) Alumina = 0.4 x 0.3 x 0.024 in. 99.5% alumina.

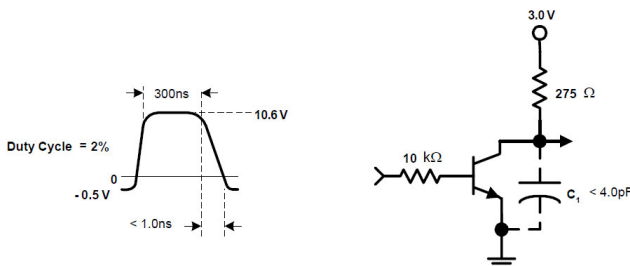


**Electrical Characteristics** ( $T_A=25^\circ\text{C}$  Unless otherwise noted)

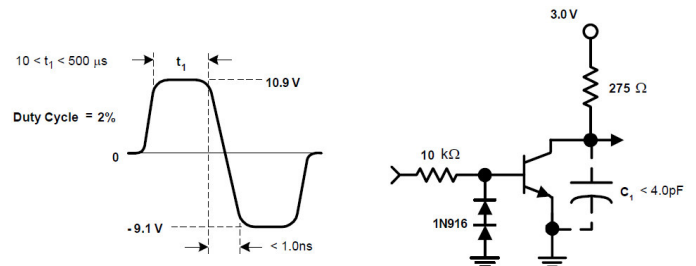
Symbol	Parameter	Test Condition	Min.	Max.	Unit
<b>Off Characteristics</b>					
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage *	$I_C = 1.0\text{mA}, I_B = 0$	40		V
$V_{(BR)CBO}$	Collector-Base Breakdown Voltage	$I_C = 10\mu\text{A}, I_E = 0$	60		V
$V_{(BR)EBO}$	Emitter-Base Breakdown Voltage	$I_E = 10\mu\text{A}, I_C = 0$	6.0		V
$I_{BL}$	Base Cutoff Current	$V_{CE} = 30\text{V}, V_{EB} = 3\text{V}$		50	nA
$I_{CEX}$	Collector Cutoff Current	$V_{CE} = 30\text{V}, V_{EB} = 3\text{V}$		50	nA
<b>On Characteristics *</b>					
$h_{FE}$	DC Current Gain	$I_C = 0.1\text{mA}, V_{CE} = 1.0\text{V}$	40		
		$I_C = 1.0\text{mA}, V_{CE} = 1.0\text{V}$	70		
		$I_C = 10\text{mA}, V_{CE} = 1.0\text{V}$	100	300	
		$I_C = 50\text{mA}, V_{CE} = 1.0\text{V}$	60		
		$I_C = 100\text{mA}, V_{CE} = 1.0\text{V}$	30		
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C = 10\text{mA}, I_B = 1.0\text{mA}$		0.2	V
		$I_C = 50\text{mA}, I_B = 5.0\text{mA}$		0.3	
$V_{BE(sat)}$	Base-Emitter Saturation Voltage	$I_C = 10\text{mA}, I_B = 1.0\text{mA}$	0.65	0.85	V
		$I_C = 50\text{mA}, I_B = 5.0\text{mA}$		0.95	
<b>Small Signal Characteristics</b>					
$f_T$	Current Gain - Bandwidth Product	$I_C = 10\text{mA}, V_{CE} = 20\text{V}, f = 100\text{MHz}$	300		MHz
$C_{obo}$	Output Capacitance	$V_{CB} = 5.0\text{V}, I_E = 0, f = 1.0\text{MHz}$		4.0	pF
$C_{ibo}$	Input Capacitance	$V_{EB} = 0.5\text{V}, I_C = 0, f = 1.0\text{MHz}$		8.0	pF
NF	Noise Figure	$I_C = 100\mu\text{A}, V_{CE} = 5.0\text{V}, R_S = 1.0\text{k}\Omega, f = 1.0\text{kHz}$		5.0	dB
$h_{ie}$	Input Impedance	$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}, f = 1.0\text{kHz}$	1.0	10	k $\Omega$
$h_{re}$	Voltage Feedback Ratio	$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}, f = 1.0\text{kHz}$	0.5	8.0	X10 <sup>-4</sup>
$h_{fe}$	Small-Signal Current Gain	$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}, f = 1.0\text{kHz}$	100	400	
$h_{oe}$	Output Admittance	$V_{CE} = 10\text{V}, I_C = 1.0\text{mA}, f = 1.0\text{kHz}$	1.0	40	umhos
<b>Switching Characteristics</b>					
$t_d$	Delay Time	$V_{CC} = 3.0\text{V}, V_{BE} = 0.5\text{V}$		35	ns
$t_r$	Rise Time	$I_C = 10\text{mA}, I_{B1} = 1.0\text{mA}$		35	ns
$t_s$	Storage Time	$V_{CC} = 3.0\text{V}, I_C = 10\text{mA}, I_{B1} = I_{B2} = 1.0\text{mA}$		200	ns
$t_f$	Fall Time			50	ns

\* Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2.0\%$

**Test Circuits**



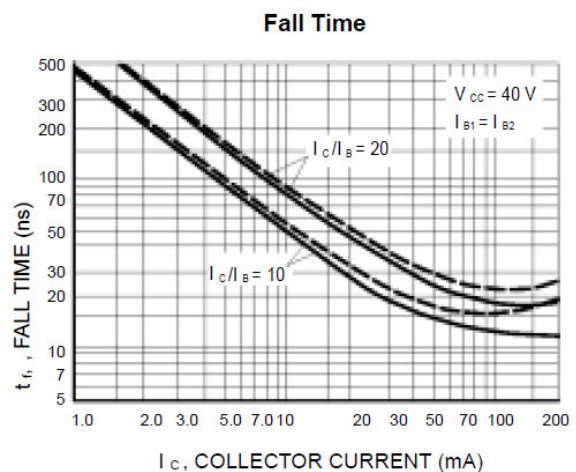
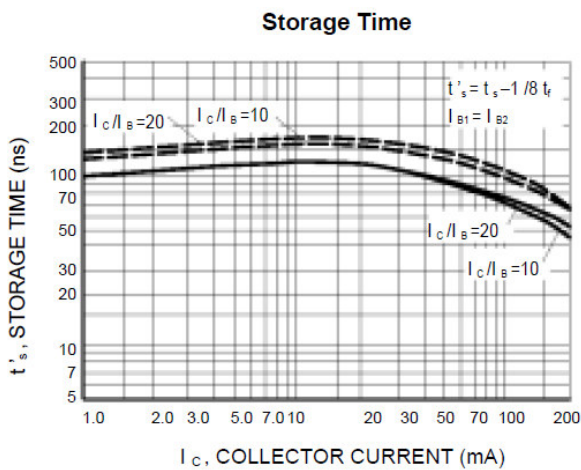
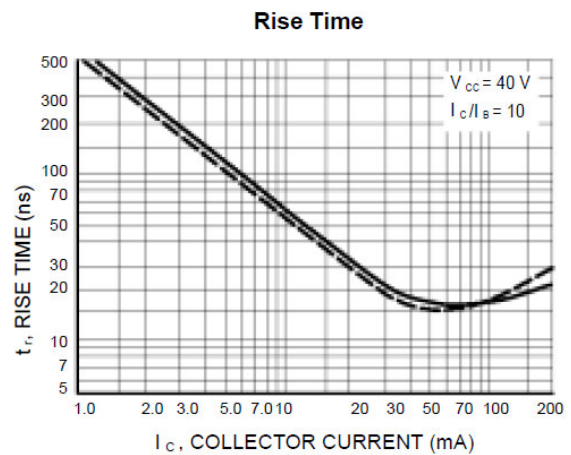
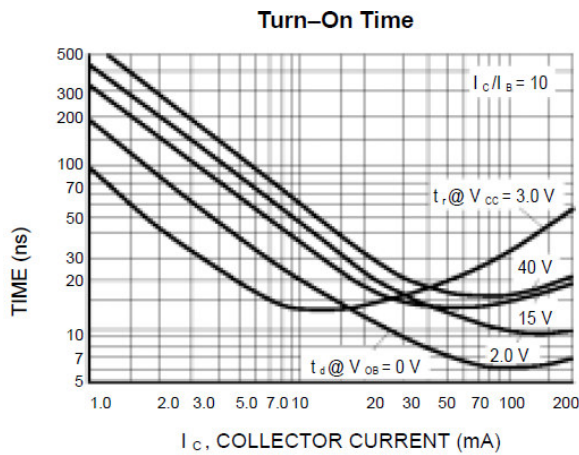
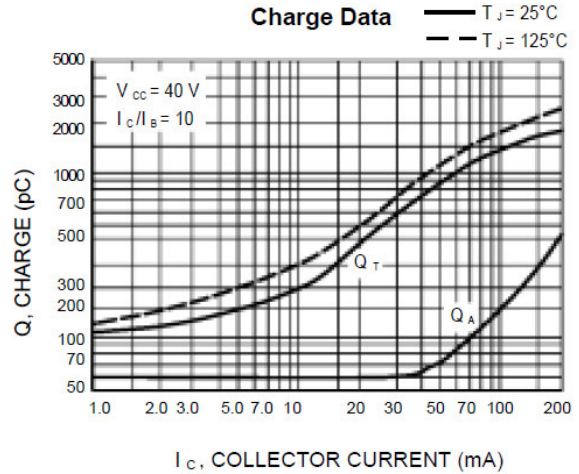
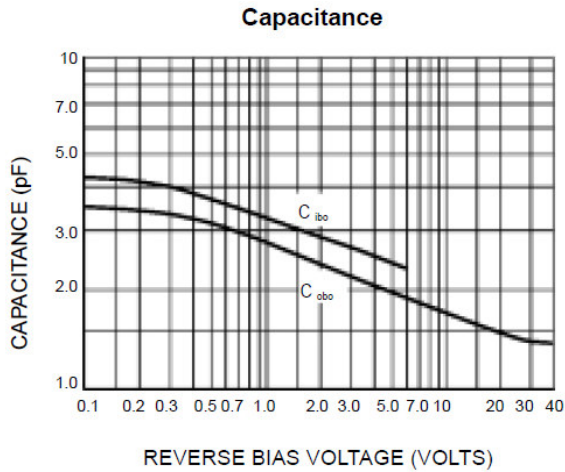
**Figure 1: Delay and Rise Time Equivalent Test Circuit**



**Figure 2: Storage and Fall Time Equivalent Test Circuit**



## Typical Characteristics (TRANSIENT)

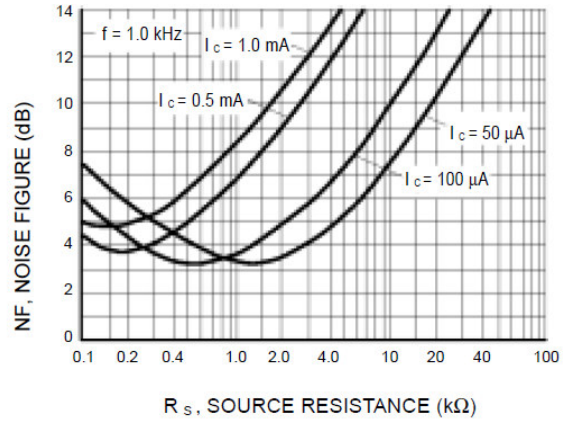
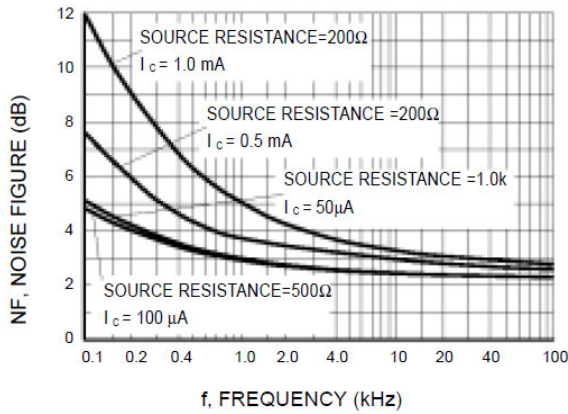




**Typical Characteristics (AUDIO SMALL-SIGNAL)**

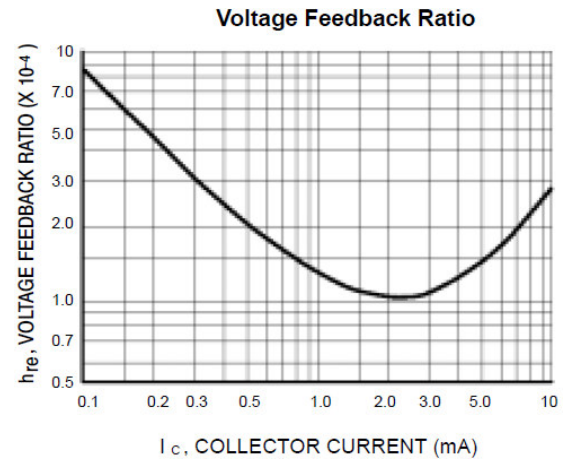
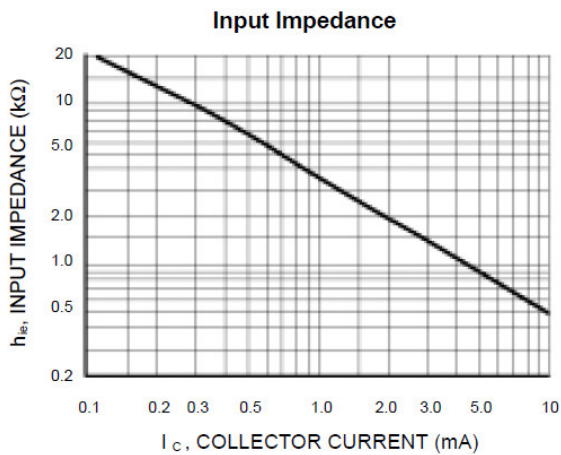
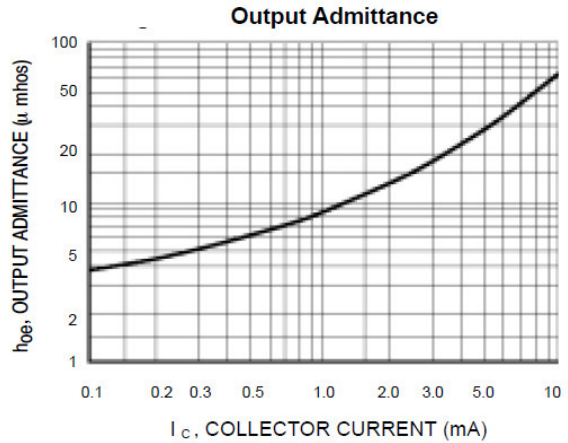
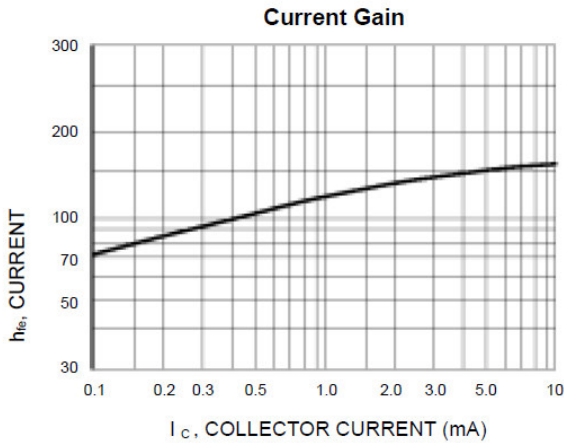
**NOISE FIGURE VARIATIONS**

( $V_{CE} = 5.0$  Vdc,  $T_A = 25^\circ\text{C}$ , Bandwidth = 1.0 Hz)



**h PARAMETERS**

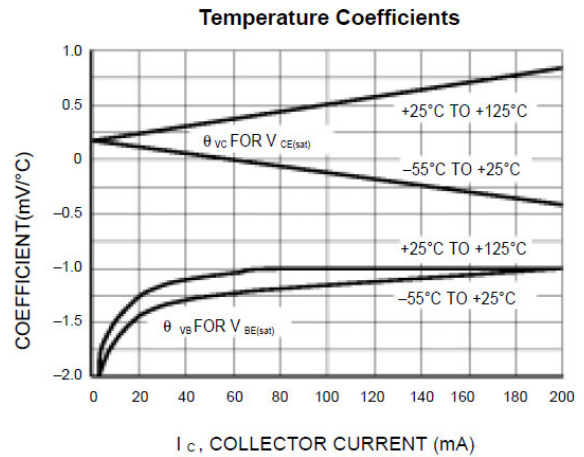
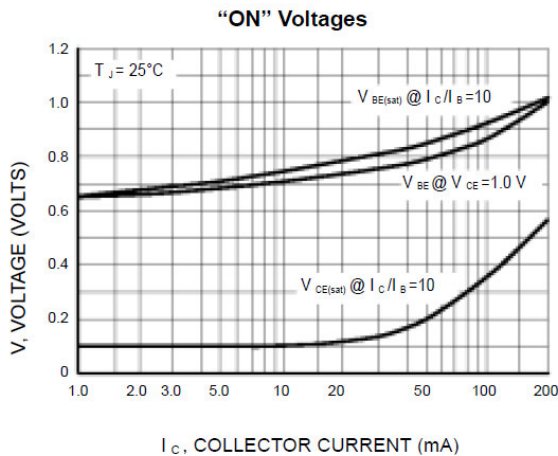
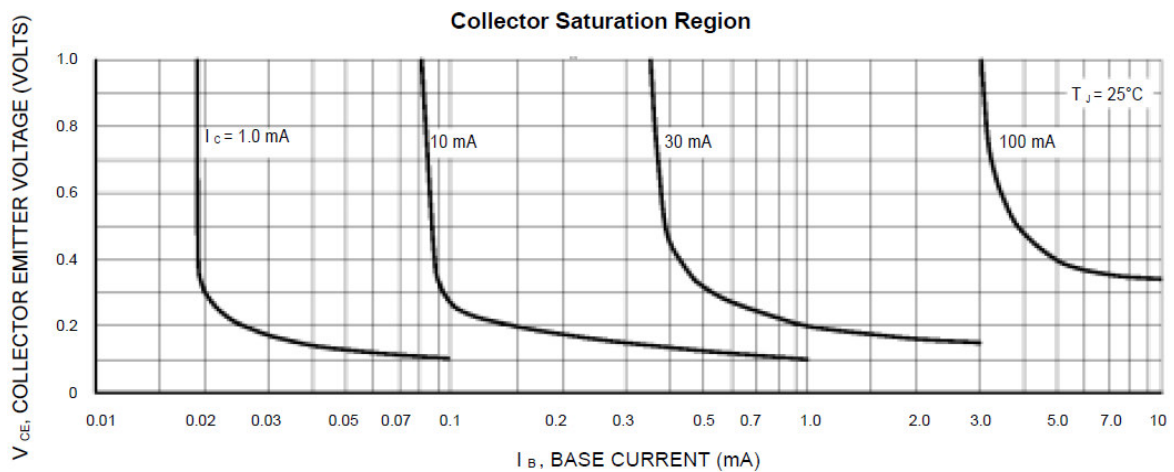
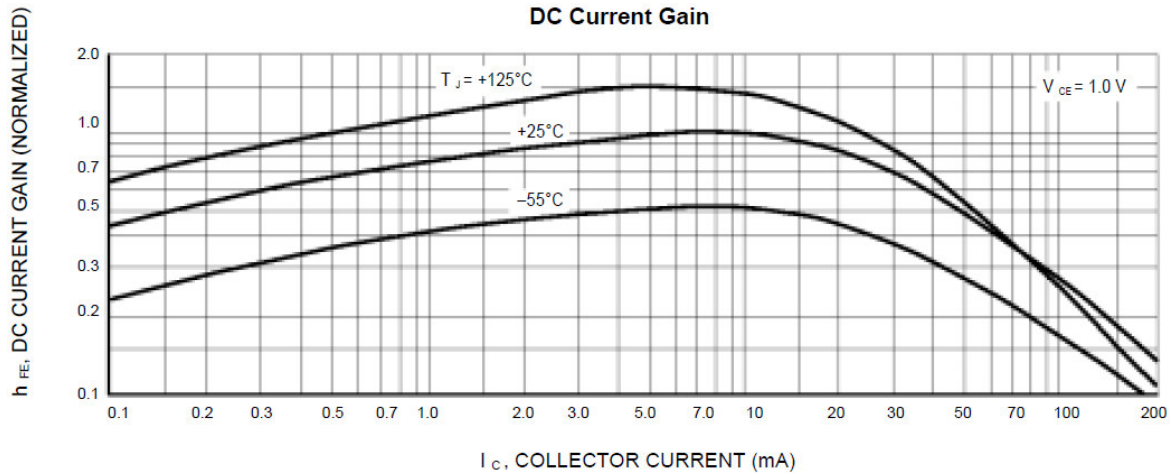
( $V_{CE} = 10$  Vdc,  $f = 1.0$  kHz,  $T_A = 25^\circ\text{C}$ )





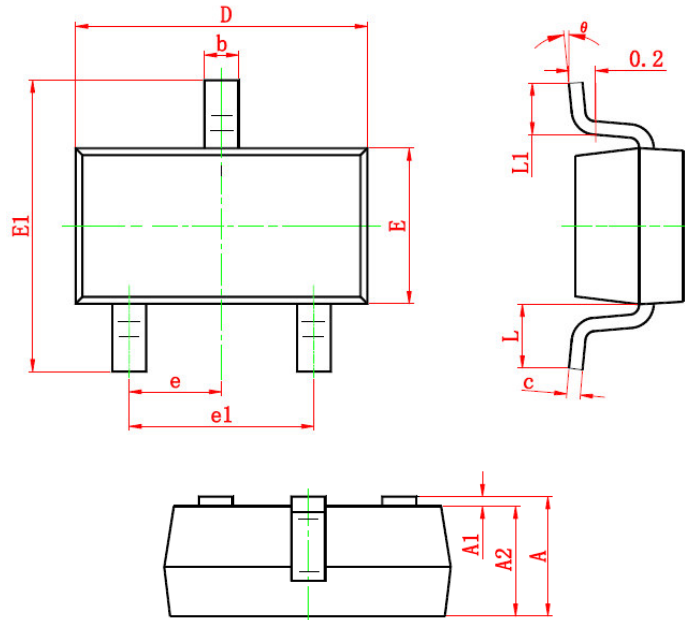


**Typical Characteristics (STATIC)**





**Package Information ( SOT-23 )**



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.900	1.200	0.035	0.043
A1	0.000	0.100	0.000	0.004
A2	0.900	1.100	0.035	0.039
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP		0.037 TYP	
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022 REF	
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	6°

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